

Notice of References Cited

Application/Control No.

10/772,315

Applicant(s)/Patent Under
Reexamination
YOON ET AL.

Examiner

MARIA VERONICA D. EWALD

Art Unit

1791

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,656,104	08-1997	Imamura et al.	148/325
*	B	US-4,390,485	06-1983	Yang, Wen-Jei	264/449
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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